

Case Docket Number: 56937-091

Customer Number: 20277

UTILITY PATENT APPLICATION UNDER 37 CFR 1.53(b)

Mail Stop Utility Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450



Sir:

Transmitted herewith for filing is the patent application of:

INVENTOR: Yukio SUGIMURA, Jun OGAWA

FOR: TECHNIQUE FOR TESTABILITY OF SEMICONDUCTOR INTEGRATED

CIRCUIT

Enclose	ed are:
\boxtimes	33 pages of specification, claims, abstract.
	Declaration and Power of Attorney.
\boxtimes	Priority Claimed.
	Certified copy of Japanese Patent Application No. P2002-270069
\boxtimes	12 sheets of formal drawing.
	An assignment of the invention to
	and the assignment recordation fee.
	An associate power of attorney.
\boxtimes	Information Disclosure Statement, Form PTO-1449 and references.
\boxtimes	Return Receipt Postcard
=	•

Respectfully submitted,

MCDERMOTT, WILL & EMERY

Michael Et Fogarty Registration No. 36,139

600 13th Street, N.W. Washington, DC 20005-3096 (202) 756-8000 MEF:mw Facsimile: (202) 756-8087

Date: September 17, 2003